ATF-33143

Low Noise Pseudomorphic HEMT in a Surface Mount Plastic Package

Data Sheet



Description

Avago's ATF-33143 is a high dynamic range, low noise PHEMT housed in a 4-lead SC-70 (SOT-343) surface mount plastic package.

Based on its featured performance, ATF-33143 is ideal for the first or second stage of base station LNA due to the excellent combination of low noise figure and enhanced linearity^[1]. The device is also suitable for applications in Wireless LAN, WLL/RLL, MMDS, and other systems requiring super low noise figure with good intercept in the 450 MHz to 10 GHz frequency range.

Note:

1. From the same PHEMT FET family, the smaller geometry ATF-34143 may also be considered for the higher gain performance, particularly in the higher frequency band (1.8 GHz and up).

Surface Mount Package SOT-343



Pin Connections and Package Marking



Note:

Top View. Package marking provides orientation and identification. "3P" = Device code

"x" = Date code character. A new character is assigned for each month, year.

Features

- Lead-free Option Available
- Low Noise Figure
- Excellent Uniformity in Product Specifications
- 1600 micron Gate Width
- Low Cost Surface Mount Small Plastic Package SOT-343 (4 lead SC-70)
- Tape-and-Reel Packaging Option Available

Specifications

1.9 GHz; 4V, 80 mA (Typ.)

- 0.5 dB Noise Figure
- 15 dB Associated Gain
- 22 dBm Output Power at 1 dB Gain Compression
- 33.5 dBm Output 3rd Order Intercept

Applications

- Tower Mounted Amplifier, Low Noise Amplifier and Driver Amplifier for GSM/TDMA/CDMA Base Stations
- LNA for Wireless LAN, WLL/RLL and MMDS Applications
- General Purpose Discrete PHEMT for other Ultra Low Noise Applications



Attention: Observe precautions for handling electrostatic sensitive devices. ESD Machine Model (Class A) ESD Human Body Model (Class 0) Refer to Avago Application Note A004R: Electrostatic Discharge Damage and Control.

ATF-33143 Absolute Maximum Ratings^[1]

			Absolute
Symbol	Parameter	Units	Maximum
V _{DS}	Drain - Source Voltage ^[2]	V	5.5
V _{GS}	Gate - Source Voltage ^[2]	V	-5
V _{GD}	Gate Drain Voltage ^[2]	V	-5
I _{DS}	Drain Current ^[2]	mA	I _{dss} ^[3]
P _{diss}	Total Power Dissipation ^[4]	mW	600
P _{in max}	RF Input Power	dBm	20
T _{CH}	Channel Temperature ^[5]	°C	160
T _{STG}	Storage Temperature	°C	-65 to 160
θ _{jc}	Thermal Resistance ^[6]	°C/W	145

Notes:

- 1. Operation of this device above any one of these parameters may cause permanent damage.
- 2. Assumes DC quiesent conditions.
- 3. $V_{GS} = 0 V$
- 4. Source lead temperature is 25°C. Derate 6 mW/°C for $T_L > 60$ °C.
- Please refer to failure rates in reliability section to assess the reliability impact of running devices above a channel temperature of 140°C.
- 6. Thermal resistance measured using 150°C Liquid Crystal Measurement method.

Product Consistency Distribution Charts^[8, 9]



Figure 1. Typical Pulsed I-V Curves^[7]. (V_{GS}=-0.2 V per step)



Figure 3. OIP3 @ 2 GHz, 4V, 80 mA. LSL=30.0, Nominal=33.3, USL=37.0



Figure 2. NF @ 2 GHz, 4 V, 80 mA. LSL=0.2, Nominal=0.53, USL=0.8



Figure 4. Gain @ 2 GHz, 4 V, 80 mA. LSL=13.5, Nominal=14.8, USL=16.5

Notes:

- 7. Under large signal conditions, V_{GS} may swing positive and the drain current may exceed I_{dss}. These conditions are acceptable as long as the maximum P_{diss} and P_{in max} ratings are not exceeded.
- 8. Distribution data sample size is 450 samples taken from 9 different wafers. Future wafers allocated to this product may have nominal values anywhere within the upper and lower spec limits.
- 9. Measurements made on production test board. This circuit represents a trade-off between an optimal noise match and a realizeable match based on production test requirements. Circuit losses have been de-embedded from actual measurements.
- 10. The probability of a parameter being between $\pm 1\sigma$ is 68.3%, between $\pm 2\sigma$ is 95.4% and between $\pm 3\sigma$ is 99.7%.

Symbol	Parameters and Test Cond	itions		Units	Min.	Typ. ^[2]	Max.
I _{dss} ^[1]	Saturated Drain Current		$V_{DS} = 1.5 V, V_{GS} = 0 V$	mA	175	237	305
V _P ^[1]	Pinchoff Voltage		V_{DS} = 1.5 V, I_{DS} = 10% of I_{dss}	V	-0.65	-0.5	-0.35
l _d	Quiescent Bias Current		$V_{GS} = -0.5 V, V_{DS} = 4 V$	mA	_	80	_
g _m ^[1]	Transconductance		$V_{DS} = 1.5 \text{ V}, \text{ g}_{\text{m}} = \text{I}_{\text{dss}}/\text{V}_{\text{P}}$	mmho	360	440	_
I _{GDO}	Gate to Drain Leakage C	lurrent	$V_{GD} = 5 V$	μΑ			1000
l _{gss}	Gate Leakage Current		$V_{GD} = V_{GS} = -4 V$	μΑ	_	42	600
		f = 2 GHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dB		0.5	0.8
NF	Noise Figure		$V_{DS} = 4 V$, $I_{DS} = 60 mA$			0.5	
INI	Noise rigure	f = 900 MHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dB		0.4	
			$V_{DS} = 4 V, I_{DS} = 60 mA$			0.4	
		f = 2 GHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dB	13.5	15	16.5
G.	Associated Gain ^[3]		$V_{DS} = 4 V, I_{DS} = 60 mA$			15	
U _d	Absociated Gam	f = 900 MHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dB		21	
			$V_{DS} = 4 V, I_{DS} = 60 mA$			21	
		f = 2 GHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dBm	30	33.5	
OIP3	Output 3 rd Order	5 dBm Pout/Tone	$V_{DS} = 4 V, I_{DS} = 60 mA$			32	
011 9	Intercept Point ^[3]	f = 900 MHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dBm		32.5	
		5 dBm Pout/Tone	$V_{DS} = 4 V$, $I_{DS} = 60 mA$			31	
		f = 2 GHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dBm		22	
P	1 dB Compressed		$V_{DS} = 4 V$, $I_{DS} = 60 mA$			21	
• 1dB	Compressed Power ^[3]	f = 900 MHz	$V_{DS} = 4 V$, $I_{DS} = 80 mA$	dBm		21	
			$V_{DS} = 4 V$, $I_{DS} = 60 mA$			20	

ATF-33143 DC Electrical Specifications $T_A = 25^{\circ}C$, RF parameters measured in a test circuit for a typical device

Notes:

1. Guaranteed at wafer probe level.

2. Typical value determined from a sample size of 450 parts from 9 wafers.

3. Measurements obtained using production test board described in Figure 5.



Figure 5. Block diagram of 2 GHz production test board used for Noise Figure, Associated Gain, P1dB, and OIP3 measurements. This circuit represents a trade-off between an optimal noise match and a realizable match based on production test requirements. Circuit losses have been de-embedded from actual measurements.

ATF-33143 Typical Performance Curves



Figure 6. OIP3, IIP3 vs. Bias^[1] at 2 GHz.



Figure 7. OIP3, IIP3 vs. Bias^[1] at 900 MHz.



Figure 8. P_{1dB} vs. Bias^[1,2] at 2 GHz.



Figure 10. NF and Ga vs. Bias^[1] at 2 GHz.



Figure 9. P_{1dB} vs. $Bias^{\left[1,2\right]}$ Tuned for NF @ 4V, 80 mA at 900 MHz.



Notes:

- 1. Measurements made on a fixed tuned production test board that was tuned for optimal gain match with reasonable noise figure at 4V 80 mA bias. This circuit represents a trade-off between optimal noise match, maximum gain match and a realizable match based on production test board requirements. Circuit losses have been de-embedded from actual measurements.
- Quiescent drain current, I_{DSQ}, is set with zero RF drive applied. As P_{1dB} is approached, the drain current may increase or decrease depending on frequency and dc bias point. At lower values of I_{DSQ} the device is running closer to class B as power output approaches P_{1dB}. This results in higher P_{1dB} and higher PAE (power added efficiency) when compared to a device that is driven by a constant current source as is typically done with active biasing.

ATF-33143 Typical Performance Curves, continued



Figure 12. F_{min} vs. Frequency and Current at 4V.



Figure 14. Fmin and Ga vs. Frequency and Temp at $V_{DS} = 4V$, $I_{DS} = 80$ mA.





Figure 13. Associated Gain vs. Frequency and Current at 4V.



Figure 15. P_{1dB}, OIP3 vs. Frequency and Temp at $V_{DS} = 4V$, $I_{DS} = 80$ mA.



5.8 GHz.

Notes:

- 1. Measurements made on a fixed tuned test fixture that was tuned for noise figure at 4V 80 mA bias. This circuit represents a trade-off between optimal noise match, maximum gain match and a realizable match based on production test requirements. Circuit losses have been deembedded from actual measurements.
- Quiescent drain current, I_{DSQ}, is set with zero RF drive applied. As P_{1dB} is approached, the drain current may increase or decrease depending on 2. frequency and dc bias point. At lower values of I_{dsa} the device is running closer to class B as power output approaches P_{1db}. This results in higher P_{1dB} and higher PAE (power added efficiency) when compared to a device that is driven by a constant current source as is typically done with active biasing.

ATF-33143 Typical Performance Curves, continued



Note:

1. Measurements made on a fixed tuned test board that was tuned for optimal gain match with reasonable noise figure at 4V 80 mA bias. This circuit represents a trade-off between an optimal noise match, maximum gain match and a realizable match based on production test board requirements. Circuit losses have been de-embedded from actual measurements.

Freq (GHz)	P _{1dB} (dBm)	l _d (mA)	G _{1dB} (dB)	PAE _{1dB} (%)	P _{3dB} (dBm)	l _d (mA)	PAE _{3dB} (%)	Γ Out_mag (Mag.)	Γ Out_ang (°)
0.9	20.7	89	23.2	33	23.2	102	51	0.39	160
1.5	21.2	91	20.7	36	23.8	116	51	0.43	165
1.8	21.1	80	19.2	40	23.0	94	52	0.43	170
2.0	21.6	81	18.1	44	23.2	89	57	0.42	174
4.0	23.0	97	11.9	48	24.6	135	48	0.40	-150
6.0	24.0	130	5.9	36	25.2	136	36	0.37	-124

ATF-33143 Power Parameters Tuned for Max P_{1dB} , $V_{DS} = 4$ V, $I_{DSQ} = 80$ mA



Figure 20. Swept Power Tuned for Max P_{1dB} $V_{DS}\!=\!4V,\,I_{DSQ}\!=\!80$ mA, 2 GHz.

Notes:

- 1. Measurements made on ATN LP1 power load pull system.
- 2. Quicescent drain current, I_{DSQ} is set with zero RF drive applied. As P_{1dB} is approached, the drain current may increase or decrease depending on frequency and dc bias point. At lower values of I_{DSQ} the device is running closer to class B as power output approaches P_{1dB} . This results in higher P_{1dB} and higher PAE (power added efficiency) when compared to a device that is driven by a constant current source as is typically done with active biasing.
- 3. PAE (%) = (($P_{out} P_{in}$) / P_{dc}) X 100
- 4. Gamma out is the reflection coefficient of the matching circuit presented to the output of the device.

Freq.	9	S ₁₁		S ₂₁			S ₁₂		9	522	MSG/MAG
(GHz)	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.	(dB)
0.5	0.88	-72.70	22.08	12.81	134.40	-27.02	0.045	54.50	0.28	-118.70	24.54
0.8	0.79	-112.10	19.46	9.41	111.20	-24.13	0.062	40.70	0.37	-149.90	21.81
1.0	0.78	-119.80	18.86	8.86	106.50	-23.93	0.064	38.00	0.38	-155.40	21.41
1.5	0.75	-149.60	16.11	6.44	88.30	-22.57	0.075	29.80	0.42	-176.20	19.34
1.8	0.74	-162.80	14.70	5.47	79.80	-22.14	0.079	26.80	0.45	174.70	18.40
2.0	0.74	-170.10	13.84	4.94	74.80	-21.84	0.082	24.90	0.46	169.40	17.80
2.5	0.74	172.30	11.98	3.98	63.00	-21.24	0.088	20.80	0.49	160.10	16.56
3.0	0.75	159.10	10.37	3.31	53.10	-20.68	0.094	17.10	0.51	152.10	15.46
4.0	0.75	137.00	7.95	2.50	35.00	-19.59	0.106	9.30	0.53	139.20	13.73
5.0	0.76	117.20	6.20	2.05	17.20	-18.56	0.119	-0.70	0.54	124.70	11.44
6.0	0.78	98.10	4.69	1.73	-1.30	-17.83	0.129	-12.80	0.54	108.00	9.80
7.0	0.80	80.10	3.12	1.44	-19.30	-17.42	0.135	-26.00	0.57	90.40	8.35
8.0	0.83	64.50	1.68	1.22	-35.20	-17.29	0.137	-37.30	0.60	74.80	7.43
9.0	0.83	50.30	0.48	1.07	-49.30	-17.08	0.140	-46.80	0.63	62.70	6.45
10.0	0.86	36.30	-0.46	0.96	-64.30	-16.59	0.148	-58.30	0.65	50.90	6.41
11.0	0.88	21.50	-1.50	0.85	-80.20	-16.53	0.149	-71.30	0.68	37.40	6.14
12.0	0.90	7.20	-2.70	0.74	-95.80	-16.81	0.144	-83.90	0.72	21.40	5.64
13.0	0.91	-5.00	-4.24	0.62	-110.20	-17.38	0.135	-95.60	0.75	5.80	4.60
14.0	0.91	-15.50	-5.49	0.54	-121.90	-17.78	0.129	-103.90	0.77	-5.70	3.64
15.0	0.92	-27.50	-6.42	0.49	-134.20	-18.00	0.126	-113.70	0.80	-15.80	3.44
16.0	0.93	-40.50	-7.26	0.44	-146.80	-17.87	0.128	-124.20	0.82	-25.70	3.22
17.0	0.94	-52.30	-8.20	0.40	-160.40	-18.07	0.125	-136.40	0.83	-37.90	3.11
18.0	0.93	-61.20	-9.51	0.34	-171.00	-18.79	0.115	-145.10	0.85	-49.70	1.79

ATF-33143 Typical Scattering Parameters, $V_{DS} = 2V$, $I_{DS} = 40$ mA

ATF-33143 Typical Noise Parameters

 $V_{DS} = 2V_{1}I_{DS} = 40 \text{ mA}$

$V_{DS} = 2V, I_{C}$	$_{\rm S} = 40 {\rm mA}$						40
Freq.	F _{min}	Ι	opt	R _{n/50}	Ga		
GHz	dB	Mag.	Ang.	-	dB	i	<u>≘</u> 30
0.5	0.26	0.45	26.00	0.07	24.74		
0.9	0.30	0.38	42.20	0.07	21.02		20
1.0	0.31	0.36	44.80	0.07	20.36		
1.5	0.34	0.31	69.50	0.06	17.40		
1.8	0.34	0.26	93.60	0.04	16.50		
2.0	0.39	0.27	108.60	0.05	15.82		
2.5	0.51	0.28	150.70	0.03	14.59		13211-
3.0	0.53	0.32	165.60	0.03	13.13		-10 5 10 15 3
4.0	0.61	0.41	-162.10	0.04	11.27		
5.0	0.70	0.49	-136.80	0.06	9.92		
6.0	0.82	0.53	-113.60	0.11	8.70		Figure 21. MSG/MAG and $ S_{21} ^2$ vs. Frequency at 2V, 4
7.0	0.93	0.59	-91.50	0.23	7.71		
8.0	1.04	0.62	-72.60	0.38	6.69		
9.0	1.12	0.67	-55.90	0.59	6.04		
10.0	1.21	0.69	-42.20	0.77	5.73		

Notes:

1. The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATF NP5 test system. From these measurements a true F_{min} is calculated. Refer to the noise parameter application section for more information.

Freq.		S ₁₁		S ₂₁			S ₁₂		9	S ₂₂	MSG/MAG
(GHz)	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.	(dB)
0.5	0.87	-72.20	22.51	13.42	134.40	-27.20	0.044	54.40	0.27	-109.80	24.84
0.8	0.78	-111.60	19.88	9.87	111.20	-24.27	0.061	40.60	0.35	-143.70	22.09
1.0	0.77	-119.30	19.28	9.26	106.50	-24.06	0.063	37.90	0.36	-150.10	21.67
1.5	0.74	-149.00	16.52	6.73	88.30	-22.79	0.073	29.80	0.40	-172.10	19.64
1.8	0.73	-162.20	15.11	5.72	79.90	-22.34	0.077	26.90	0.42	178.40	18.71
2.0	0.73	-169.50	14.24	5.17	74.80	-22.13	0.079	25.00	0.43	172.90	18.16
2.5	0.73	172.90	12.38	4.17	63.10	-21.41	0.086	21.10	0.46	163.10	16.85
3.0	0.74	159.70	10.78	3.46	53.30	-20.91	0.091	17.50	0.48	154.80	15.80
4.0	0.74	137.60	8.37	2.62	35.20	-19.79	0.103	10.00	0.50	141.20	14.06
5.0	0.75	117.70	6.63	2.15	17.30	-18.80	0.115	0.00	0.51	126.50	11.53
6.0	0.77	98.60	5.10	1.80	-1.30	-17.99	0.126	-11.90	0.52	109.80	9.99
7.0	0.79	80.60	3.54	1.51	-19.50	-17.58	0.132	-24.90	0.55	92.10	8.57
8.0	0.82	64.90	2.10	1.28	-35.50	-17.44	0.134	-36.00	0.57	76.20	7.64
9.0	0.83	50.70	0.92	1.12	-49.60	-17.13	0.139	-45.50	0.60	64.00	6.69
10.0	0.86	36.60	-0.04	1.00	-64.90	-16.64	0.147	-57.00	0.63	52.10	6.65
11.0	0.88	21.90	-1.11	0.89	-81.00	-16.58	0.148	-70.10	0.66	38.60	6.38
12.0	0.90	7.50	-2.32	0.77	-96.80	-16.81	0.144	-82.70	0.70	22.60	6.00
13.0	0.91	-4.80	-3.86	0.64	-111.40	-17.38	0.135	-94.40	0.73	6.80	4.90
14.0	0.91	-15.40	-5.11	0.56	-123.30	-17.78	0.129	-103.00	0.76	-5.00	3.90
15.0	0.92	-27.40	-6.05	0.50	-135.90	-17.93	0.127	-112.80	0.79	-15.10	3.71
16.0	0.93	-40.40	-6.95	0.45	-148.70	-17.87	0.128	-123.40	0.81	-25.10	3.48
17.0	0.94	-52.30	-7.91	0.41	-162.30	-18.00	0.126	-135.70	0.82	-37.30	3.41
18.0	0.93	-61.30	-9.25	0.35	-172.90	-18.72	0.116	-144.30	0.84	-49.10	1.94

ATF-33143 Typical Scattering Parameters, $V_{DS} = 3 V$, $I_{DS} = 40 mA$

ATF-33143 Typical Noise Parameters

 $V_{DS} = 3 V, I_{DS} = 40 mA$

Freq.	F _{min}	Γ	opt	R _{n/50}	Ga
GHz	dB	Mag.	Ang.	-	dB
0.5	0.24	0.45	28.40	0.07	25.26
0.9	0.29	0.38	40.90	0.07	21.26
1.0	0.31	0.34	42.60	0.07	20.50
1.5	0.37	0.28	66.30	0.07	17.67
1.8	0.34	0.25	90.10	0.05	16.57
2.0	0.38	0.25	105.80	0.05	15.93
2.5	0.51	0.28	147.40	0.03	14.72
3.0	0.52	0.31	162.80	0.03	13.29
4.0	0.58	0.40	-165.20	0.03	11.45
5.0	0.68	0.46	-138.50	0.05	10.05
6.0	0.80	0.54	-115.00	0.09	8.97
7.0	0.89	0.57	-92.50	0.20	7.90
8.0	1.01	0.61	-72.80	0.35	6.90
9.0	1.09	0.65	-56.40	0.53	6.26
10.0	1.18	0.68	-42.60	0.69	5.99





Notes:

The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATF NP5 test system. From these
measurements a true F_{min} is calculated. Refer to the noise parameter application section for more information.

Freq.	9	S ₁₁		S ₂₁			S ₁₂		9	222	MSG/MAG
(GHz)	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.	(dB)
0.5	0.87	-75.30	22.95	14.06	133.00	-28.18	0.039	55.10	0.27	-124.20	25.57
0.8	0.78	-114.70	20.22	10.26	110.00	-25.19	0.055	42.60	0.36	-153.90	22.71
1.0	0.77	-122.30	19.59	9.56	105.50	-24.89	0.057	40.50	0.37	-158.80	22.24
1.5	0.74	-151.60	16.78	6.91	87.60	-23.37	0.068	33.50	0.41	-178.70	20.07
1.8	0.73	-164.60	15.35	5.87	79.30	-22.87	0.072	30.80	0.43	172.60	19.11
2.0	0.73	-171.80	14.47	5.30	74.40	-22.53	0.075	29.00	0.44	167.50	18.49
2.5	0.73	171.00	12.60	4.27	62.80	-21.76	0.082	25.10	0.47	158.50	17.17
3.0	0.74	158.10	10.99	3.54	53.10	-21.07	0.089	21.40	0.50	151.00	16.00
4.0	0.75	136.40	8.56	2.68	35.40	-19.79	0.103	13.20	0.52	138.60	14.15
5.0	0.75	116.90	6.80	2.19	17.70	-18.68	0.117	2.80	0.52	124.40	11.53
6.0	0.77	97.80	5.28	1.84	-0.60	-17.88	0.128	-9.70	0.53	107.80	10.03
7.0	0.79	79.90	3.71	1.53	-18.60	-17.42	0.135	-23.20	0.56	90.20	8.66
8.0	0.82	64.50	2.26	1.30	-34.40	-17.29	0.137	-34.60	0.59	74.70	7.75
9.0	0.83	50.40	1.07	1.13	-48.50	-17.03	0.141	-44.50	0.62	62.70	6.81
10.0	0.86	36.40	0.12	1.02	-63.50	-16.49	0.150	-56.20	0.65	50.90	6.72
11.0	0.88	21.60	-0.94	0.90	-79.50	-16.43	0.151	-69.40	0.68	37.40	6.46
12.0	0.90	7.30	-2.13	0.78	-95.10	-16.71	0.146	-82.10	0.71	21.40	6.04
13.0	0.91	-5.00	-3.67	0.66	-109.70	-17.27	0.137	-94.00	0.74	5.80	4.99
14.0	0.91	-15.50	-4.93	0.57	-121.40	-17.72	0.130	-102.70	0.77	-6.10	3.98
15.0	0.92	-27.50	-5.85	0.51	-133.90	-17.86	0.128	-112.40	0.80	-15.80	3.78
16.0	0.93	-40.60	-6.70	0.46	-146.60	-17.72	0.130	-123.00	0.82	-25.80	3.54
17.0	0.94	-52.30	-7.61	0.42	-160.30	-17.92	0.127	-135.30	0.82	-37.90	3.45
18.0	0.93	-61.40	-8.97	0.36	-170.90	-18.64	0.117	-144.00	0.84	-49.70	2.08

ATF-33143 Typical Scattering Parameters, $V_{DS} = 3 V$, $I_{DS} = 60 mA$

ATF-33143 Typical Noise Parameters

 $V_{DS} = 3 V, I_{DS} = 60 mA$

Freq.	F _{min}	Γ	opt	R _{n/50}	Ga
GHz	dB	Mag.	Ang.	-	dB
0.5	0.23	0.43	29.20	0.06	25.64
0.9	0.28	0.35	42.40	0.06	21.62
1.0	0.29	0.35	45.00	0.07	20.87
1.5	0.34	0.26	68.80	0.06	17.84
1.8	0.34	0.23	93.30	0.04	16.89
2.0	0.38	0.22	109.70	0.05	16.24
2.5	0.52	0.25	150.60	0.03	14.93
3.0	0.53	0.30	167.50	0.03	13.52
4.0	0.61	0.39	-160.30	0.04	11.65
5.0	0.68	0.47	-134.70	0.06	10.28
6.0	0.83	0.52	-112.10	0.11	9.09
7.0	0.91	0.58	-89.70	0.22	8.09
8.0	1.04	0.61	-71.50	0.36	7.07
9.0	1.09	0.66	-54.80	0.56	6.43
10.0	1.13	0.70	-41.40	0.73	6.15





Notes:

The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATF NP5 test system. From these
measurements a true F_{min} is calculated. Refer to the noise parameter application section for more information.

Freq.	9	5 ₁₁		S ₂₁			S ₁₂		9	S ₂₂	MSG/MAG
(GHz)	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.	(dB)
0.5	0.87	-72.50	22.73	13.74	134.30	-27.39	0.043	54.10	0.26	-104.90	25.04
0.8	0.78	-111.80	20.07	10.09	111.00	-24.42	0.060	40.40	0.33	-140.20	22.26
1.0	0.77	-119.40	19.46	9.43	106.40	-24.20	0.062	37.70	0.34	-147.10	21.82
1.5	0.73	-149.10	16.69	6.85	88.20	-22.90	0.072	29.80	0.38	-169.70	19.78
1.8	0.72	-162.20	15.28	5.82	79.80	-22.44	0.076	26.90	0.40	-179.30	18.84
2.0	0.72	-169.50	14.41	5.26	74.70	-22.23	0.078	25.00	0.41	175.10	18.29
2.5	0.72	173.00	12.55	4.24	63.00	-21.58	0.084	21.20	0.44	165.10	17.03
3.0	0.73	159.80	10.95	3.53	53.20	-21.07	0.089	17.80	0.46	156.50	15.98
4.0	0.74	137.70	8.54	2.68	35.10	-19.93	0.101	10.40	0.48	142.50	14.23
5.0	0.75	117.90	6.80	2.19	17.10	-18.92	0.113	0.70	0.49	127.70	11.54
6.0	0.77	98.80	5.28	1.84	-1.60	-18.11	0.124	-11.20	0.50	111.00	10.07
7.0	0.79	80.80	3.72	1.54	-19.80	-17.68	0.130	-24.10	0.53	93.40	8.68
8.0	0.82	65.10	2.29	1.30	-35.90	-17.50	0.133	-35.10	0.56	77.30	7.77
9.0	0.83	50.90	1.10	1.14	-50.20	-17.23	0.137	-44.60	0.59	64.90	6.80
10.0	0.86	36.80	0.15	1.02	-65.60	-16.69	0.146	-56.10	0.62	53.00	6.78
11.0	0.88	22.00	-0.93	0.90	-81.80	-16.58	0.148	-69.10	0.65	39.50	6.55
12.0	0.90	7.60	-2.14	0.78	-97.60	-16.81	0.144	-81.70	0.69	23.50	6.13
13.0	0.91	-4.70	-3.69	0.66	-112.40	-17.32	0.136	-93.50	0.72	7.50	5.03
14.0	0.91	-15.30	-4.97	0.57	-124.50	-17.78	0.129	-102.10	0.76	-4.30	4.06
15.0	0.92	-27.20	-5.92	0.51	-137.30	-17.93	0.127	-112.20	0.79	-14.60	3.87
16.0	0.93	-40.30	-6.85	0.46	-150.10	-17.79	0.129	-122.80	0.81	-24.50	3.62
17.0	0.94	-52.20	-7.83	0.41	-163.80	-18.00	0.126	-135.10	0.82	-36.80	3.54
18.0	0.93	-61.20	-9.19	0.35	-174.60	-18.72	0.116	-143.80	0.84	-48.70	2.05

ATF-33143 Typical Scattering Parameters, $V_{DS} = 4 V$, $I_{DS} = 40 mA$

ATF-33143 Typical Noise Parameters

 $V_{DS} = 4 V$, $I_{DS} = 40 mA$

Freq.	F _{min}	Г	opt	R _{n/50}	G _a
GHz	dB	Mag.	Ang.	-	dB
0.5	0.30	0.44	31.50	0.08	25.59
0.9	0.33	0.36	42.70	0.07	21.43
1.0	0.34	0.33	44.50	0.08	20.63
1.5	0.38	0.26	68.70	0.06	17.72
1.8	0.37	0.25	90.70	0.05	16.65
2.0	0.40	0.23	106.40	0.05	15.99
2.5	0.53	0.27	145.80	0.04	14.70
3.0	0.54	0.31	162.00	0.03	13.32
4.0	0.60	0.38	-165.30	0.04	11.47
5.0	0.68	0.46	-138.80	0.05	10.17
6.0	0.82	0.49	-115.40	0.09	8.93
7.0	0.89	0.56	-93.20	0.19	7.99
8.0	1.00	0.60	-73.10	0.33	7.00
9.0	1.07	0.66	-56.60	0.50	6.40
10.0	1.16	0.68	-42.80	0.65	6.11



Notes:

The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATF NP5 test system. From these
measurements a true F_{min} is calculated. Refer to the noise parameter application section for more information.

Freq.	9	S ₁₁		S ₂₁			S ₁₂			S ₂₂	MSG/MAG
(GHz)	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.	(dB)
0.5	0.86	-75.60	23.20	14.45	132.90	-28.18	0.039	54.80	0.26	-118.50	25.69
0.8	0.77	-115.00	20.45	10.53	109.80	-25.35	0.054	42.20	0.34	-150.00	22.90
1.0	0.76	-122.50	19.80	9.77	105.30	-25.04	0.056	40.20	0.35	-155.50	22.42
1.5	0.73	-151.80	16.98	7.06	87.50	-23.61	0.066	33.20	0.39	-176.10	20.29
1.8	0.72	-164.60	15.55	5.99	79.20	-22.97	0.071	30.60	0.41	175.00	19.26
2.0	0.72	-171.80	14.66	5.41	74.20	-22.73	0.073	28.90	0.42	169.80	18.70
2.5	0.72	171.00	12.79	4.36	62.70	-21.94	0.080	25.10	0.45	160.60	17.36
3.0	0.73	158.20	11.17	3.62	53.00	-21.31	0.086	21.60	0.47	152.70	16.24
4.0	0.74	136.50	8.76	2.74	35.20	-20.00	0.100	13.70	0.49	139.90	13.79
5.0	0.75	117.00	7.00	2.24	17.50	-18.86	0.114	3.40	0.50	125.70	11.57
6.0	0.77	98.00	5.48	1.88	-1.00	-17.99	0.126	-8.90	0.51	109.10	10.15
7.0	0.79	80.20	3.92	1.57	-19.00	-17.52	0.133	-22.30	0.54	91.60	8.80
8.0	0.82	64.70	2.48	1.33	-34.90	-17.39	0.135	-33.60	0.57	75.90	7.88
9.0	0.83	50.60	1.29	1.16	-49.10	-17.08	0.140	-43.40	0.60	63.70	6.92
10.0	0.86	36.60	0.34	1.04	-64.30	-16.54	0.149	-55.20	0.63	52.00	6.92
11.0	0.88	21.80	-0.72	0.92	-80.40	-16.48	0.150	-68.40	0.66	38.50	6.69
12.0	0.90	7.50	-1.94	0.80	-96.20	-16.71	0.146	-81.10	0.70	22.50	6.27
13.0	0.91	-4.80	-3.48	0.67	-110.80	-17.27	0.137	-92.90	0.73	6.70	5.14
14.0	0.91	-15.40	-4.73	0.58	-122.80	-17.65	0.131	-101.60	0.76	-5.20	4.12
15.0	0.92	-27.30	-5.68	0.52	-135.40	-17.79	0.129	-111.60	0.79	-15.20	3.90
16.0	0.93	-40.40	-6.56	0.47	-148.30	-17.72	0.130	-122.20	0.81	-25.10	3.72
17.0	0.94	-52.20	-7.54	0.42	-162.10	-17.92	0.127	-134.70	0.82	-37.30	3.59
18.0	0.93	-61.20	-8.87	0.36	-172.80	-18.56	0.118	-143.30	0.84	-49.20	2.19

ATF-33143 Typical Scattering Parameters, $V_{DS} = 4 V$, $I_{DS} = 60 \text{ mA}$

ATF-33143 Typical Noise Parameters

 $V_{DS} = 4 V$, $I_{DS} = 60 mA$

Freq.	F _{min}	Г	opt	R _{n/50}	Ga
GHz	dB	Mag.	Ang.	-	dB
0.5	0.29	0.42	31.40	0.08	25.91
0.9	0.33	0.33	44.70	0.07	21.80
1.0	0.34	0.32	48.00	0.07	21.00
1.5	0.38	0.26	71.90	0.06	18.14
1.8	0.39	0.22	94.00	0.05	16.96
2.0	0.42	0.22	109.70	0.05	16.29
2.5	0.47	0.25	149.40	0.03	14.95
3.0	0.51	0.29	166.80	0.03	13.58
4.0	0.63	0.39	-160.60	0.04	11.74
5.0	0.72	0.46	-135.30	0.06	10.36
6.0	0.82	0.51	-112.40	0.11	9.17
7.0	0.93	0.57	-90.90	0.21	8.18
8.0	1.03	0.61	-71.80	0.37	7.19
9.0	1.13	0.66	-55.50	0.55	6.56
10.0	1.22	0.69	-41.80	0.72	6.29



Notes:

The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATF NP5 test system. From these
measurements a true F_{min} is calculated. Refer to the noise parameter application section for more information.

Freq.		S ₁₁		S ₂₁			S ₁₂		9	522	MSG/MAG
(GHz)	Mag.	Ang.	dB	Mag.	Ang.	dB	Mag.	Ang.	Mag.	Ang.	(dB)
0.5	0.86	-77.20	23.39	14.76	132.20	-28.82	0.036	55.30	0.26	-125.40	26.13
0.8	0.77	-116.60	20.60	10.71	109.20	-25.86	0.051	43.40	0.34	-154.80	23.22
1.0	0.76	-124.00	19.93	9.91	104.80	-25.49	0.053	41.70	0.36	-159.50	22.72
1.5	0.73	-153.00	17.09	7.15	87.10	-23.86	0.064	35.20	0.39	-179.10	20.48
1.8	0.72	-165.80	15.66	6.06	78.90	-23.31	0.068	32.70	0.41	172.40	19.50
2.0	0.72	-172.90	14.77	5.47	74.00	-22.95	0.071	31.00	0.42	167.30	18.87
2.5	0.72	170.10	12.89	4.41	62.50	-22.03	0.079	27.20	0.45	158.50	17.47
3.0	0.73	157.40	11.27	3.66	53.00	-21.39	0.085	23.50	0.48	151.00	16.34
4.0	0.74	136.00	8.84	2.77	35.30	-20.00	0.100	15.30	0.50	138.80	13.59
5.0	0.75	116.70	7.09	2.26	17.70	-18.86	0.114	4.80	0.51	124.80	11.56
6.0	0.77	97.70	5.57	1.90	-0.70	-17.99	0.126	-7.80	0.52	108.40	10.17
7.0	0.79	80.00	4.00	1.58	-18.70	-17.47	0.134	-21.30	0.55	90.90	8.84
8.0	0.82	64.50	2.55	1.34	-34.50	-17.34	0.136	-32.80	0.58	75.40	7.93
9.0	0.83	50.50	1.36	1.17	-48.70	-17.03	0.141	-42.80	0.61	63.30	6.98
10.0	0.86	36.50	0.43	1.05	-63.80	-16.49	0.150	-54.60	0.63	51.60	6.96
11.0	0.88	21.70	-0.65	0.93	-79.90	-16.38	0.152	-67.80	0.66	38.10	6.73
12.0	0.90	7.40	-1.85	0.81	-95.60	-16.66	0.147	-80.60	0.70	22.10	6.26
13.0	0.91	-4.80	-3.39	0.68	-110.20	-17.21	0.138	-92.60	0.73	6.40	5.21
14.0	0.91	-15.40	-4.64	0.59	-122.00	-17.59	0.132	-101.10	0.76	-5.00	4.20
15.0	0.92	-27.30	-5.57	0.53	-134.80	-17.79	0.129	-111.20	0.79	-15.40	3.98
16.0	0.93	-40.40	-6.46	0.47	-147.60	-17.65	0.131	-121.90	0.81	-25.30	3.73
17.0	0.94	-52.20	-7.40	0.43	-161.40	-17.85	0.128	-134.30	0.82	-37.50	3.65
18.0	0.93	-61.20	-8.75	0.36	-172.10	-18.56	0.118	-143.10	0.84	-49.30	2.24

ATF-33143 Typical Scattering Parameters, $V_{DS} = 4 V$, $I_{DS} = 80 mA$

ATF-33143 Typical Noise Parameters

 $V_{DS} = 4 V$, $I_{DS} = 80 mA$

Freq. GHz	F _{min} dB	Г Мад.	opt Ana.	R _{n/50}	G _a dB
0.5	0.30	0.42	34.50	0.08	26.23
0.9	0.35	0.32	46.40	0.07	21.96
1.0	0.35	0.32	50.40	0.07	21.16
1.5	0.40	0.23	74.80	0.06	18.47
1.8	0.42	0.20	98.80	0.05	17.18
2.0	0.45	0.19	114.10	0.05	16.48
2.5	0.49	0.23	153.70	0.04	15.09
3.0	0.55	0.28	171.50	0.03	13.70
4.0	0.68	0.38	-156.70	0.04	11.85
5.0	0.75	0.48	-133.30	0.07	10.49
6.0	0.90	0.52	-110.70	0.13	9.27
7.0	1.00	0.57	-89.60	0.25	8.27
8.0	1.12	0.62	-70.80	0.43	7.28
9.0	1.19	0.67	-54.60	0.65	6.66
10.0	1.33	0.69	-40.80	0.85	6.31



Figure 26. MSG/MAG and $|S_{21}|^2$ vs. Frequency at 4V, 80 mA.

Notes:

1. The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATF NP5 test system. From these measurements a true F_{min} is calculated. Refer to the noise parameter application section for more information.

Noise Parameter Applications Information

 F_{min} values at 2 GHz and higher are based on measurements while the F_{mins} below 2 GHz have been extrapolated. The F_{min} values are based on a set of 16 noise figure measurements made at 16 different impedances using an ATN NP5 test system. From these measurements, a true F_{min} is calculated. F_{min} represents the true minimum noise figure of the device when the device is presented with an impedance matching network that transforms the source impedance, typically 50Ω , to an impedance represented by the reflection coefficient Γ_{o} . The designer must design a matching network that will present Γ_{o} to the device with minimal associated circuit losses. The noise figure of the completed amplifier is equal to the noise figure of the device plus the losses of the matching network preceding the device. The noise figure of the device is equal to F_{min} only when the device is presented with Γ_{o} . If the reflection coefficient of the matching network is other than $\Gamma_{o'}$ then the noise figure of the device will be greater than F_{min} based on the following equation.

$$NF = F_{min} + 4 \frac{R_n}{Zo} \frac{|\Gamma_s - \Gamma_o|^2}{(|1 + \Gamma_o|^2)(1 - \Gamma_s|^2)}$$

Where R_n/Z_o is the normalized noise resistance, Γ_o is the optimum reflection coefficient required to produce F_{min} and Γ_s is the reflection coefficient of the source impedance actually presented to the device. The losses of the matching networks are non-zero and they will also add to the noise figure of the device creating a higher amplifier noise figure. The losses of the matching networks are related to the Q of the components and associated printed circuit board loss. Γ_o is typically fairly low at higher frequencies and increases as frequency is lowered. Larger gate width devices will typically have a lower Γ_o as compared to narrower gate width devices.

Typically for FETs, the higher Γ_0 usually infers that an impedance much higher than 50Ω is required for the device to produce F_{min}. At VHF frequencies and even lower L Band frequencies, the required impedance can be in the vicinity of several thousand ohms. Matching to such a high impedance requires very hi-Q components in order to minimize circuit losses. As an example at 900 MHz, when airwwound coils (Q>100) are used for matching networks, the loss can still be up to 0.25 dB which will add directly to the noise figure of the device. Using muiltilayer molded inductors with Qs in the 30 to 50 range results in additional loss over the airwound coil. Losses as high as 0.5 dB or greater add to the typical 0.15 dB F_{min} of the device creating an amplifier noise figure of nearly 0.65 dB. A discussion concerning calculated and measured circuit losses and their effect on amplifier noise figure is covered in Avago Application 1085.

	Nominal Failures per million (FPM) for different durations					90% confidence Failures per million (FPM) for different durations				
Channel Temperature (°C)	(FITs) 1000 hours	1 year	5 year	10 year	30 year	(FITs) 1000 hours	1 year	5 year	10 year	30 year
100	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1
125	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	<0.1	11
140	<0.1	<0.1	<0.1	<0.1	160	<0.1	<0.1	6	160	9.3K
150	<0.1	<0.1	2	140	26K	<0.1	0.3	780	8800	131K
160	<0.1	<0.1	920	21K	370K	<0.1	67	24K	120K	520K
180 NOT	<0.1	4400	450K	830K	1000K	21	53K	590K	850K	1000K

Reliability Data

Predicted failures with temperature extrapolated from failure distribution and activation energy data of higher temperature operational life STRIFE of PHEMT process

ATF-33143 Die Model



Statz Model MESFETM1

NFET=yes

PFET=no Vto=-0.95

Beta=0.48

Alpha=4

Tnom=27

B=0.8

ldstc=

Tau=

Vbi=0.7

Betatce=

Delta2=

Gscap=3

Delta1=0.2

Lambda=0.09

Cgs=1.6 pF Gdcap=3 Cgd=0.32 pF Rgd= Tqm= Vmax= Fc= Rd=.125 Rg=1 Rs=0.0625 Ld=0.00375 nH Lg=0.00375 nH Ls=0.00125 nH Cds=0.08 pF Crf=0.1

Rc=62.5 Gsfwd=1 Gdrev=0 Gdfwd=1 Gdrev=0 Vjr=1 Is=1 nA Ir=1 nA Ir=1 nA Ir=1 nA Ir=1 nA Ir=2 nA

Taumd1=no Fnc=1E6 R=0.17 C=0.2 P=0.65 wVgfwd= wBvgs= wBvgs= wBvds= wldsmax= wPmax= Al IParams=

This model can be used as a design tool. It has been tested on MDS for various specifications. However, for more precise and accurate design, please refer to the measured data in this data sheet. For future improvements Avago reserves the right to change these models without prior notice.

ATF-33143 Model



Part Number Ordering Information

	No. of	
Part Number	Devices	Container
ATF-33143-TR1G	3000	7" Reel
ATF-33143-TR2G	10000	13" Reel
ATF-33143-BLKG	100	antistatic bag

Package Dimensions SC-70 4L/SOT-343





	DIMENSIO	NS (mm)
CVMPOL	AAINI	
SIMBOL	MIN.	MAX.
E	1.15	1.35
D	1.85	2.25
HE	1.80	2.40
A	0.80	1.10
A2	0.80	1.00
A1	0.00	0.10
b	0.15	0.40
b1	0.55	0.70
c	0.10	0.20
1	0.10	0.46



NOTES:

- 1. All dimensions are in mm.
- 2. Dimensions are inclusive of plating.
- 3. Dimensions are exclusive of mold flash & metal burr.
- 4. All specifications comply to EIAJ SC70.
- 5. Die is facing up for mold and facing down for trim/form, ie: reverse trim/form.
- 6. Package surface to be mirror finish.

Recommended PCB Pad Layout for Avago's SC70 4L/SOT-343 Products



Dimensions in $\frac{mm}{(inches)}$

Device Orientation



Tape Dimensions and Product Orientation For Outline 4T



For product information and a complete list of distributors, please go to our web site: www.avagotech.com

b site: www.avagotecn.con

Avago, Avago Technologies, and the A logo are trademarks of Avago Technologies in the United States and other countries. Data subject to change. Copyright © 2005-2012 Avago Technologies. All rights reserved. Obsoletes 5989-3747EN AV02-1442EN - June 8, 2012



X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for RF JFET Transistors category:

Click to view products by Broadcom manufacturer:

Other Similar products are found below :

XF1001-SC-EV1 CE3514M4 CE3514M4-C2 CE3520K3-C1 CE3521M4 CE3521M4-C2 NPT25100B CE3520K3 CGH55030F1 CGH27030F QPD0020 CGH25120F CMPA801B030F TGF2023-2-01 TGF2023-2-02 CGH40006P QPD1009 MAGX-011086 QPD1014SR T2G6000528-Q3 CG2H40025F CGHV40200PP CGHV40050F CGHV14800F CGH27030P CGH09120F CG2H80015D-GP4 CG2H40045F T2G4003532-FL TGF2942 T2G6003028-FS T2G6000528-Q3 28V T2G4003532-FS T1G2028536-FL QPD1015 QPD1010 QPD1008L QPD1008 QPD1000 JANTXV2N4858 ATF-521P8-BLK J175D26Z AGX-1/2 CE3512K2 2N3819 CGH55030F2 CGHV40180F CGHV27015S MMZ25332BT1 NPT2021